

AO4435

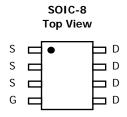
P-Channel Enhancement Mode Field Effect Transistor

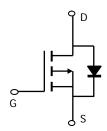
General Description

The AO4435 uses advanced trench technology to provide excellent $R_{DS(ON)}$, and ultra-low low gate charge with a 25V gate rating. This device is suitable for use as a load switch or in PWM applications. Standard Product AO4435 is Pb-free (meets ROHS & Sony 259 specifications).

Features

$$\begin{split} &V_{DS} = -30V \\ &I_{D} = -10A \qquad (V_{GS} = -10V) \\ &R_{DS(ON)} < 18 m\Omega \; (V_{GS} = -10V) \\ &R_{DS(ON)} < 36 m\Omega \; (V_{GS} = -5V) \end{split}$$





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	10 Sec	Steady State	Units		
Drain-Source Voltage		V_{DS}	-30		V		
Gate-Source Voltage		V_{GS}	±25		V		
Continuous Drain Current ^A	T _A =25°C		-10	-8			
	T _A =70°C	I _D	-8	-6	Α		
Pulsed Drain Current ^B		I _{DM}	-80				
Power Dissipation ^A	T _A =25°C	Р	3.1	1.7	W		
	T _A =70°C	$-P_{D}$	2.0	1.1	VV		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150		°C		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s		32	40	°C/W			
Maximum Junction-to-Ambient ^A	Steady State	$R_{\scriptscriptstyle{ hetaJA}}$	60	75	°C/W			
Maximum Junction-to-Lead ^C	Steady State	$R_{\scriptscriptstyle{ hetaJL}}$	17	24	°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V				
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -30V, V_{GS} = 0V$			-1	μА				
	Cata Dady lackage surrent	$T_{J} = 55^{\circ}C$			-5					
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 25V$	4 7	0.0	±100	nA V				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_{D} = -250 \mu A$	-1.7	-2.3	-3	V				
I _{D(ON)}	On state drain current	$V_{GS} = -10V, V_{DS} = -5V$	-80			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -10V, I_D = -10A$ $T_{J} = 125^{\circ}C$		15	18					
		$V_{GS} = -5V, I_D = -5A$		22 27	27 36	mΩ				
9 FS	Forward Transconductance	$V_{DS} = -5V, I_D = -10A$		22	- 30	S				
V _{SD}	Diode Forward Voltage	$I_S = -1A, V_{GS} = 0V$		-0.74	-1	V				
$\overline{I_S}$	Maximum Body-Diode Continuous Current				-3.5	Α				
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			1130	1400	pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-15V, f=1MHz		240		pF				
C _{rss}	Reverse Transfer Capacitance			155		pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		5.8	8	Ω				
SWITCHII	NG PARAMETERS									
$Q_{g(10V)}$	Total Gate Charge			18	24	nC				
$Q_{g(4.5V)}$	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-10A		9.5						
$\overline{Q_gs}$	Gate Source Charge	V _{GS} 10V, V _{DS} 13V, I _D 10A		5.5		nC				
Q_{gd}	Gate Drain Charge			3.3		nC				
$t_{D(on)}$	Turn-On DelayTime			8.7		ns				
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_L =1.5 Ω ,		8.5		ns				
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		18		ns				
t _f	Turn-Off Fall Time]		7		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =-10A, dI/dt=100A/μs		25	30	ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =-10A, dI/dt=100A/μs		12		nC				

A: The value of R $_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.
- D. The static characteristics in Figures 1 to 6 are obtained using < 300 μs pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating.
- F. The current rating is based on the $t \leqslant 10\mbox{s}$ thermal resistance rating.
- G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_i=25C.

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